


<b>Search Notes</b> 	<b>Application/Control No.</b> 10784488	<b>Applicant(s)/Patent Under Reexamination</b> WEN ET AL.
	<b>Examiner</b> Lee, Douglas S	<b>Art Unit</b> 2125

SEARCHED			
Class	Subclass	Date	Examiner
700	28,099-102,108-109, and 121	12/21/06	dl

SEARCH NOTES		
Search Notes	Date	Examiner
East database searched	12/21/06	dl

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner